Triple buffer with open-drain output Rev. 11 — 9 April 2013

Product data sheet

#### **General description** 1.

The 74LVC3G07 provides three non-inverting buffers.

The output of the device is an open-drain and can be connected to other open-drain outputs to implement active-LOW wired-OR or active-HIGH wired-AND functions.

Input can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

Schmitt trigger action at all inputs makes the circuit tolerant for slower input rise and fall time.

This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

#### Features and benefits 2.

- Wide supply voltage range from 1.65 V to 5.5 V
- 5 V tolerant input/output for interfacing with 5 V logic
- High noise immunity
- Complies with JEDEC standard:
  - JESD8-7 (1.65 V to 1.95 V)
  - JESD8-5 (2.3 V to 2.7 V)
  - JESD8-B/JESD36 (2.7 V to 3.6 V).
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V
- –24 mA output drive (V<sub>CC</sub> = 3.0 V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Inputs accept voltages up to 5 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C.



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### 3. Ordering information

Table 1. Orde	ring information			
Type number	Package			
	Temperature range	Name	Description	Version
74LVC3G07DP	–40 °C to +125 °C	TSSOP8	plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm	SOT505-2
74LVC3G07DC	–40 °C to +125 °C	VSSOP8	plastic very thin shrink small outline package; 8 leads; body width 2.3 mm	SOT765-1
74LVC3G07GT	–40 °C to +125 °C	XSON8	plastic extremely thin small outline package; no leads; 8 terminals; body 1 $\times$ 1.95 $\times$ 0.5 mm	SOT833-1
74LVC3G07GF	–40 °C to +125 °C	XSON8	extremely thin small outline package; no leads; 8 terminals; body $1.35 \times 1 \times 0.5$ mm	SOT1089
74LVC3G07GD	–40 °C to +125 °C	XSON8	plastic extremely thin small outline package; no leads; 8 terminals; body $3 \times 2 \times 0.5$ mm	SOT996-2
74LVC3G07GM	–40 °C to +125 °C	XQFN8	plastic, extremely thin quad flat package; no leads; 8 terminals; body $1.6 \times 1.6 \times 0.5$ mm	SOT902-2
74LVC3G07GN	–40 °C to +125 °C	XSON8	extremely thin small outline package; no leads; 8 terminals; body $1.2 \times 1.0 \times 0.35$ mm	SOT1116
74LVC3G07GS	–40 °C to +125 °C	XSON8	extremely thin small outline package; no leads; 8 terminals; body $1.35 \times 1.0 \times 0.35$ mm	SOT1203

### 4. Marking

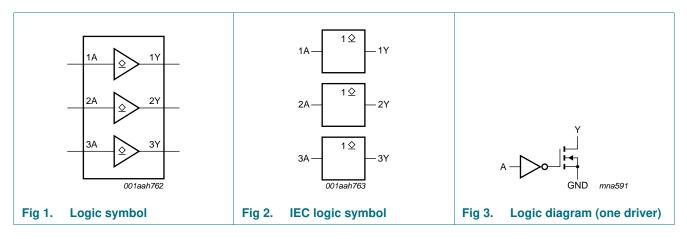
#### Table 2. Marking codes

Type number	Marking code <sup>[1]</sup>
74LVC3G07DP	V07
74LVC3G07DC	V07
74LVC3G07GT	V07
74LVC3G07GF	V7
74LVC3G07GD	V07
74LVC3G07GM	V07
74LVC3G07GN	V7
74LVC3G07GS	V7

[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

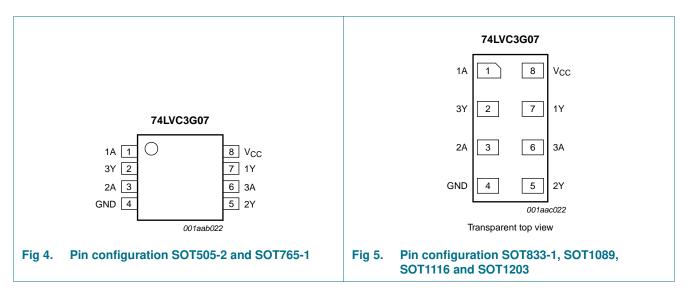
Triple buffer with open-drain output

### 5. Functional diagram

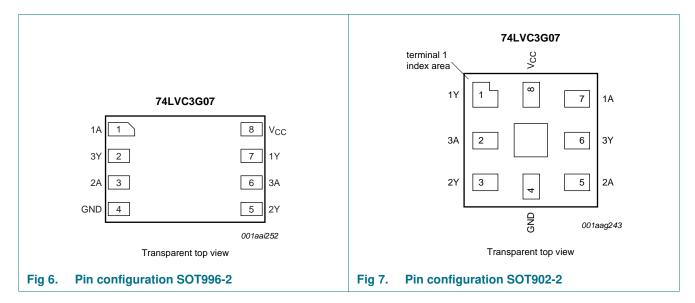


### 6. Pinning information

### 6.1 Pinning



Triple buffer with open-drain output



### 6.2 Pin description

Symbol	Pin	Description	
	SOT505-2, SOT765-1, SOT833-1, SOT1089, SOT996-2, SOT1116 and SOT1203	SOT902-2	
1A, 2A, 3A	1, 3, 6	7, 5, 2	data input
GND	4	4	ground (0 V)
1Y, 2Y, 3Y	7, 5, 2	1, 3, 6	data output
V <sub>CC</sub>	8	8	supply voltage

### 7. Functional description

#### Table 4.Function table[1]

Input nA	Output nY
L	L
Н	Z

[1] H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

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#### Triple buffer with open-drain output

### 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

			0	(0	/
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input clamping current	V <sub>1</sub> < 0 V	-50	-	mA
VI	input voltage		<u>[1]</u> –0.5	+6.5	V
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
Vo	output voltage	Active mode	<u>[1]</u> –0.5	+6.5	V
		Power-down mode	<u>[1][2]</u> –0.5	+6.5	V
lo	output current	$V_{O} = 0 V$ to 6.5 V	-	50	mA
I <sub>CC</sub>	supply current		-	100	mA
I <sub>GND</sub>	ground current		-100	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to \ +125 \ ^{\circ}C$	<u>[3]</u> _	250	mW

[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] When  $V_{CC}$  = 0 V (Power-down mode), the output voltage can be 5.5 V in normal operation.

[3] For TSSOP8 package: above 55 °C the value of P<sub>tot</sub> derates linearly with 2.5 mW/K.
 For VSSOP8 package: above 110 °C the value of P<sub>tot</sub> derates linearly with 8 mW/K.
 For XSON8 and XQFN8 packages: above 118 °C the value of P<sub>tot</sub> derates linearly with 7.8 mW/K.

### 9. Recommended operating conditions

Table 6.	Operating conditions				
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		1.65	5.5	V
VI	input voltage		0	5.5	V
Vo	output voltage	Active mode	0	5.5	V
		Power-down mode; $V_{CC} = 0 V$	0 5.5	5.5	V
T <sub>amb</sub>	ambient temperature		-40	+125	°C
$\Delta t / \Delta V$	input transition rise and fall rate	$V_{CC}$ = 1.65 V to 2.7 V	-	20	ns/V
		$V_{CC} = 2.7 \text{ V} \text{ to } 5.5 \text{ V}$	-	10	ns/V

### **10. Static characteristics**

#### Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$T_{amb} = -40$	°C to +85 °C[1]					
VIH	HIGH-level input	V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
	voltage	$V_{CC} = 2.3 \text{ V} \text{ to } 2.7 \text{ V}$	1.7	-	-	V
		$V_{CC} = 2.7 \text{ V} \text{ to } 3.6 \text{ V}$	2.0	-	-	V
		$V_{CC} = 4.5 \text{ V} \text{ to } 5.5 \text{ V}$	$0.7\times V_{CC}$	-	-	V
V <sub>IL</sub>	LOW-level input	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V
	voltage	$V_{CC} = 2.3 \text{ V} \text{ to } 2.7 \text{ V}$	-	-	0.7	V
		$V_{CC} = 2.7 \text{ V} \text{ to } 3.6 \text{ V}$	-	-	0.8	V
		$V_{CC} = 4.5 \text{ V} \text{ to } 5.5 \text{ V}$	-	-	$0.3\times V_{CC}$	V
	LOW-level output	$V_I = V_{IH} \text{ or } V_{IL}$				
	voltage	I <sub>O</sub> = 100 μA; V <sub>CC</sub> = 1.65 V to 5.5 V	-	-	0.1	V
		I <sub>O</sub> = 4 mA; V <sub>CC</sub> = 1.65 V	-	-	0.45	V
		$I_0 = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.3	V
		$I_{O} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.4	V
		$I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.55	V
		$I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.55	V
1	input leakage current	V <sub>I</sub> = 5.5 V or GND; V <sub>CC</sub> = 0 V to 5.5 V	[2] -	±0.1	±5	μA
OZ	OFF-state output current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{IH} \text{ or } V_{IL};  V_{O} = V_{CC} \text{ or } GND; \\ V_{CC} = 5.5 \ V \end{array}$	-	±0.1	±10	μA
OFF	power-off leakage current	$V_{\rm I}~\text{or}~V_{O}$ = 5.5 V; $V_{CC}$ = 0 V	-	±0.1	±10	μA
сс	supply current		-	0.1	10	μA
N <sub>CC</sub>	additional supply current	per pin; V <sub>CC</sub> = 2.3 V to 5.5 V; V <sub>I</sub> = V <sub>CC</sub> - 0.6 V; I <sub>O</sub> = 0 A	[2] -	5	500	μA
2 <sub>1</sub>	input capacitance		-	2.5	-	pF

#### Triple buffer with open-drain output

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = -40	) °C to +125 °C					
V <sub>IH</sub>	HIGH-level input	$V_{CC} = 1.65 \text{ V}$ to 1.95 V	$0.65 \times V_{CC}$	-	-	V
	voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.7	-	-	V
		$V_{CC} = 2.7 \text{ V} \text{ to } 3.6 \text{ V}$	2.0	-	-	V
		$V_{CC} = 4.5 \text{ V} \text{ to } 5.5 \text{ V}$	$0.7\times V_{CC}$	-	-	V
V <sub>IL</sub>	LOW-level input	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V
	voltage	$V_{CC} = 2.3 \text{ V} \text{ to } 2.7 \text{ V}$	-	-	0.7	V
		$V_{CC} = 2.7 \text{ V} \text{ to } 3.6 \text{ V}$	-	-	0.8	V
		$V_{CC}$ = 4.5 V to 5.5 V	-	-	$0.3 \times V_{CC}$	V
V <sub>OL</sub>	LOW-level output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}$				
		I <sub>O</sub> = 100 μA; V <sub>CC</sub> = 1.65 V to 5.5 V	-	-	0.1	V
		$I_{O} = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.70	V
		$I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_{O} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.60	V
		$I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.80	V
		$I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.80	V
I	input leakage current		-	-	±20	μA
l <sub>oz</sub>	OFF-state output current		-	-	±10	μA
OFF	power-off leakage current	$V_{\rm I}~\text{or}~V_{\rm O}$ = 5.5 V; $V_{CC}$ = 0 V	-	-	±20	μA
СС	supply current	$V_{I} = 5.5 \text{ V or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 \text{ V to } 5.5 \text{ V}$	-	-	40	μA
∆I <sub>CC</sub>	additional supply current	per pin; $V_{CC} = 2.3$ V to 5.5 V; $V_1 = V_{CC} - 0.6$ V; $I_0 = 0$ A	-	-	5000	μA

#### Table 7. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

[1] All typical values are measured at  $T_{amb}$  = 25 °C.

[2] These typical values are measured at  $V_{CC}$  = 3.3 V.

### **11. Dynamic characteristics**

#### Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 9.

Symbol	Parameter	Conditions		-40	°C to +85	5 °C	–40 °C to	o +125 °C	Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
t <sub>pd</sub>	propagation delay	nA to nY; see Figure 8	[2]						
		V <sub>CC</sub> = 1.65 V to 1.95 V		1.0	2.9	6.7	1.0	8.4	ns
		$V_{CC} = 2.3 \text{ V} \text{ to } 2.7 \text{ V}$		0.5	1.7	4.3	0.5	5.5	ns
		V <sub>CC</sub> = 2.7 V		1.0	2.3	4.2	1.0	5.3	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		0.5	2.1	3.7	0.5	4.7	ns
		$V_{CC} = 4.5 V \text{ to } 5.5 V$		0.5	1.5	2.9	0.5	3.7	ns
C <sub>PD</sub>	power dissipation capacitance	$V_{\rm I}$ = GND to $V_{CC};V_{CC}$ = 3.3 V	[3]	-	6.5	-	-	-	pF

[1] Typical values are measured at  $T_{amb}$  = 25 °C and  $V_{CC}$  = 1.8 V, 2.5 V, 2.7 V, 3.3 V and 5.0 V respectively.

[2]  $t_{pd}$  is the same as  $t_{PLZ}$  and  $t_{PZL}$ .

[3]  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W).

 $\label{eq:PD} \mathsf{P}_{\mathsf{D}} = \mathsf{C}_{\mathsf{P}\mathsf{D}} \times \mathsf{V}_{\mathsf{C}\mathsf{C}}{}^2 \times \mathsf{f}_i \times \mathsf{N} + \Sigma(\mathsf{C}_{\mathsf{L}} \times \mathsf{V}_{\mathsf{C}\mathsf{C}}{}^2 \times \mathsf{f}_{\mathsf{o}}) \text{ where:}$ 

 $f_i$  = input frequency in MHz;

 $f_o = output frequency in MHz;$ 

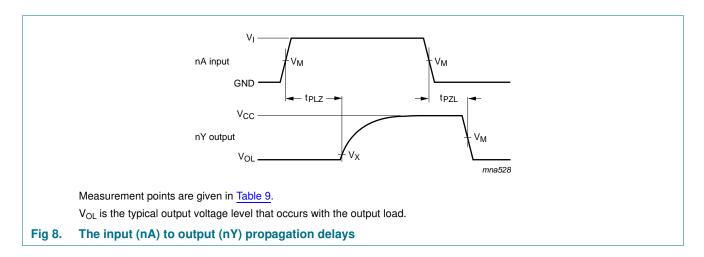
 $C_L$  = output load capacitance in pF;

 $V_{CC}$  = supply voltage in V;

N = number of inputs switching;

 $\Sigma(C_L \times V_{CC}{}^2 \times f_o) = \text{sum of outputs.}$ 

### 12. Waveforms

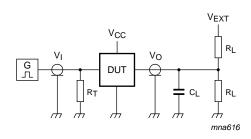


#### **NXP Semiconductors**

## 74LVC3G07

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Table 9. Measurement points				
Supply voltage	Input	Output		
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	
1.65 V to 1.95 V	$0.5  imes V_{CC}$	$0.5  imes V_{CC}$	V <sub>OL</sub> + 0.15 V	
2.3 V to 2.7 V	$0.5\times V_{CC}$	$0.5  imes V_{CC}$	V <sub>OL</sub> + 0.15 V	
2.7 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	
3.0 V to 3.6 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	
4.5 V to 5.5 V	$0.5  imes V_{CC}$	$0.5  imes V_{CC}$	V <sub>OL</sub> + 0.3 V	



Test data is given in Table 10.

Definitions for test circuit:

 $R_L$  = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_o$  of the pulse generator.

V<sub>EXT</sub> = External voltage for measuring switching times.

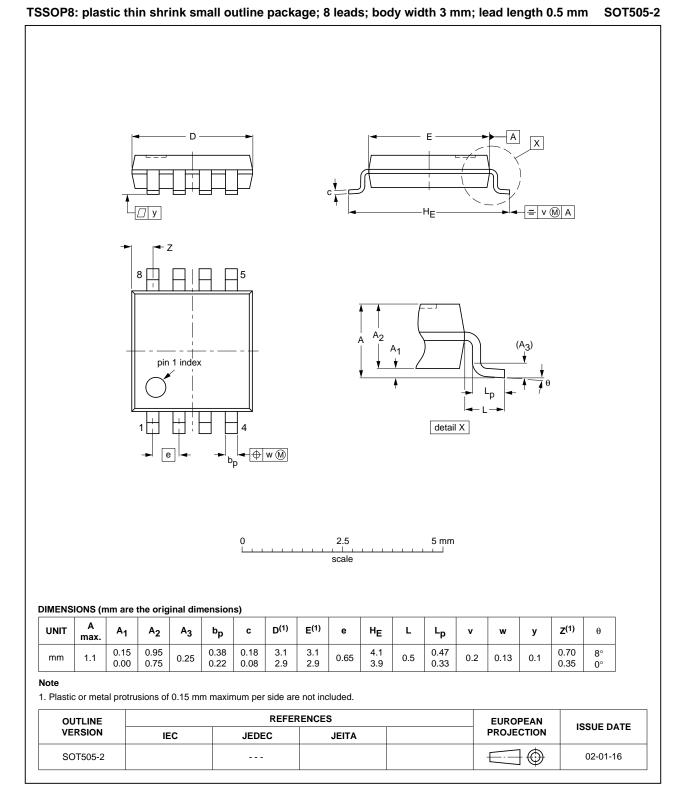
Fig 9. Test circuit for measuring switching times

#### Table 10. Test data

Supply voltage	Input	Input			V <sub>EXT</sub>
V <sub>cc</sub>	VI	t <sub>r</sub> = t <sub>f</sub>	CL	RL	t <sub>PZL</sub> , t <sub>PLZ</sub>
1.65 V to 1.95 V	V <sub>CC</sub>	$\leq$ 2.0 ns	30 pF	1 kΩ	$2 \times V_{CC}$
2.3 V to 2.7 V	V <sub>CC</sub>	$\leq$ 2.0 ns	30 pF	500 Ω	$2 \times V_{CC}$
2.7 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	6 V
3.0 V to 3.6 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	6 V
4.5 V to 5.5 V	V <sub>CC</sub>	$\leq$ 2.5 ns	50 pF	500 Ω	$2 \times V_{CC}$

Triple buffer with open-drain output

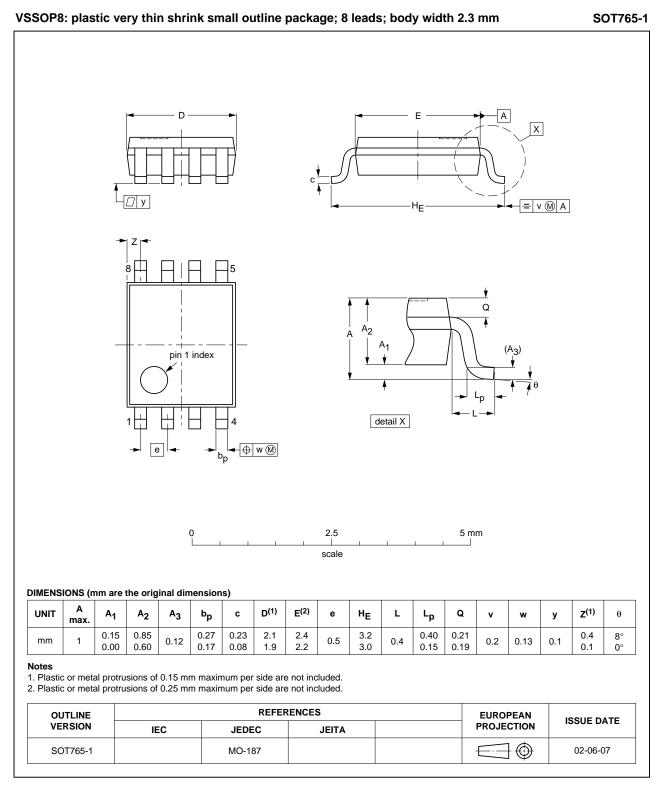
### 13. Package outline



#### Fig 10. Package outline SOT505-2 (TSSOP8)

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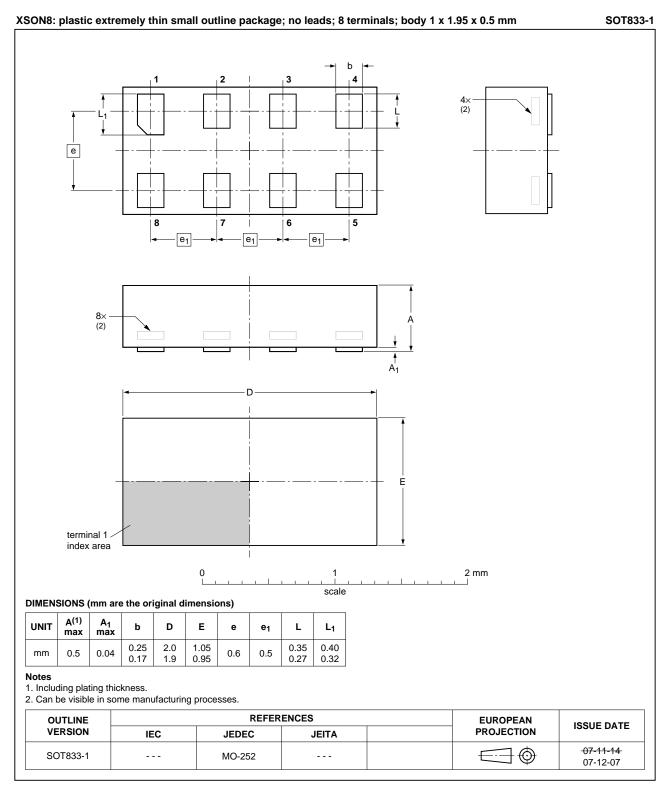
#### Triple buffer with open-drain output



#### Fig 11. Package outline SOT765-1 (VSSOP8)

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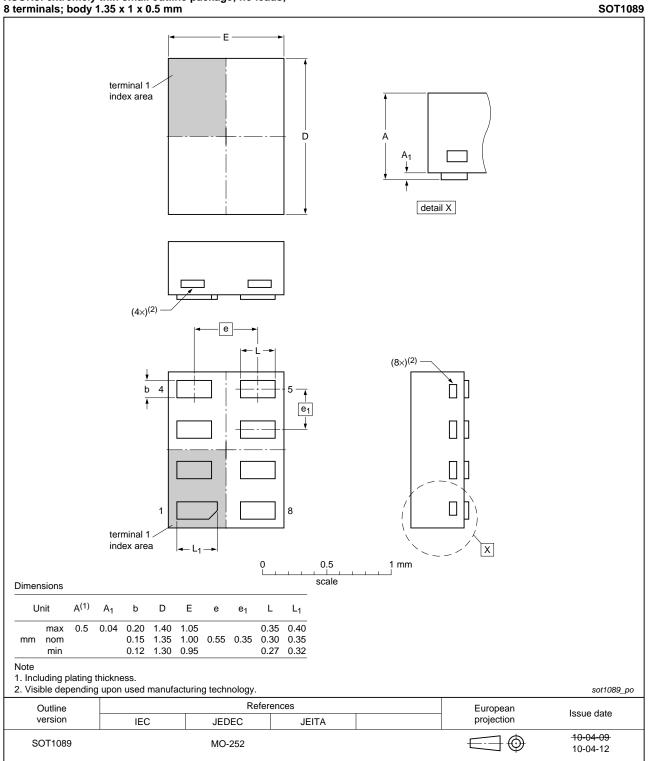
Triple buffer with open-drain output



#### Fig 12. Package outline SOT833-1 (XSON8)

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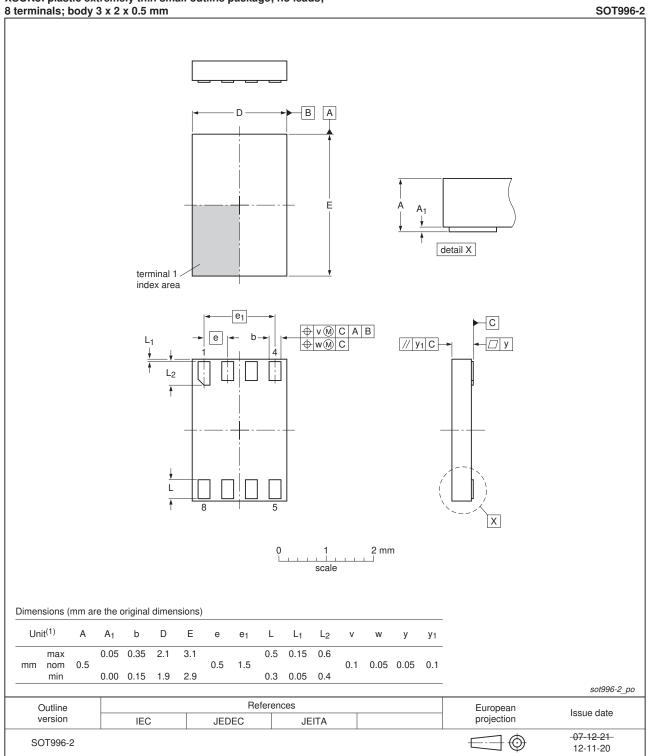
Triple buffer with open-drain output



## XSON8: extremely thin small outline package; no leads; 8 terminals; body 1.35 x 1 x 0.5 mm

Fig 13. Package outline SOT1089 (XSON8)

Triple buffer with open-drain output

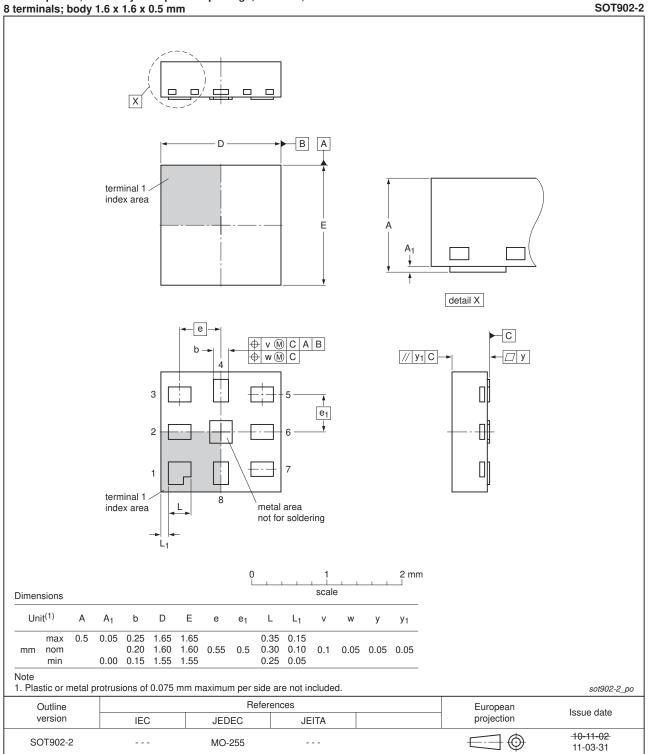


XSON8: plastic extremely thin small outline package; no leads;

Fig 14. Package outline SOT996-2 (XSON8)

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Triple buffer with open-drain output

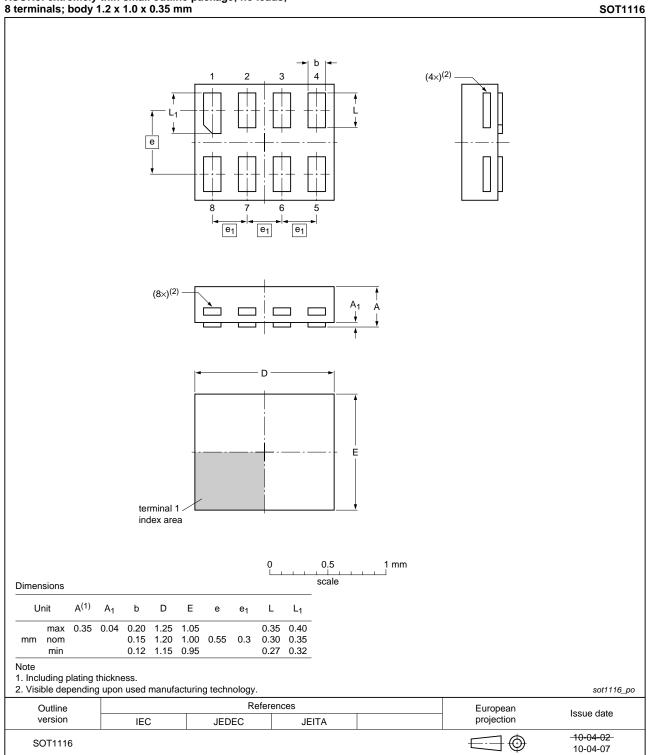


XQFN8: plastic, extremely thin quad flat package; no leads;

#### Fig 15. Package outline SOT902-2 (XQFN8)

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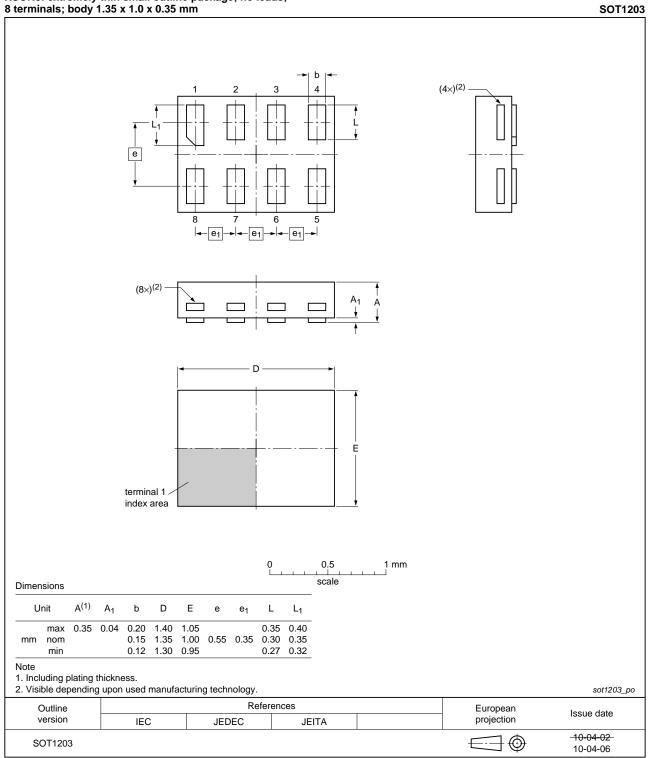
Triple buffer with open-drain output



## XSON8: extremely thin small outline package; no leads; 8 terminals; body 1.2 x 1.0 x 0.35 mm

Fig 16. Package outline SOT1116 (XSON8)

Triple buffer with open-drain output



## XSON8: extremely thin small outline package; no leads; 8 terminals; body 1.35 x 1.0 x 0.35 mm

Fig 17. Package outline SOT1203 (XSON8)

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### Triple buffer with open-drain output

### 14. Abbreviations

Table 11.	Abbreviations
Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

### 15. Revision history

ory			
Release date	Data sheet status	Change notice	Supersedes
20130409	Product data sheet	-	74LVC3G07 v.10
<ul> <li>For type nun</li> </ul>	nber 74LVC3G07GD XSON8U	has changed to XSC	ON8.
20120627	Product data sheet	-	74LVC3G07 v.9
<ul> <li>For type nun</li> </ul>	nber 74LVC3G07GM the SOT	code has changed to	SOT902-2.
20111123	Product data sheet	-	74LVC3G07 v.8
Legal pages	updated.		
20111019	Product data sheet	-	74LVC3G07 v.7
20100809	Product data sheet	-	74LVC3G07 v.6
20080616	Product data sheet	-	74LVC3G07 v.5
20080219	Product data sheet	-	74LVC3G07 v.4
20070521	Product data sheet	-	74LVC3G07 v.3
20050201	Product data sheet	-	74LVC3G07 v.2
20041027	Product data sheet	-	74LVC3G07 v.1
20040608	Product data sheet	-	-
	Release date           20130409           • For type num           20120627           • For type num           20111123           • Legal pages           20111019           20100809           20080616           20080219           20070521           20050201           20041027	Release dateData sheet status20130409Product data sheet• For type number 74LVC3G07GD XSON8U20120627Product data sheet• For type number 74LVC3G07GM the SOT20111123Product data sheet• Legal pages updated.20111019Product data sheet20100809Product data sheet20080616Product data sheet20080219Product data sheet20050201Product data sheet20050201Product data sheet20041027Product data sheet	Release dateData sheet statusChange notice20130409Product data sheet-• For type number 74LVC3G07GD XSON8U has changed to XSO20120627Product data sheet• For type number 74LVC3G07GM the SOT code has changed to XSO20111123Product data sheet• Legal pages updated.20111019Product data sheet20100809Product data sheet20080616Product data sheet20070521Product data sheet20050201Product data sheet20041027Product data sheet

### 16. Legal information

#### 16.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

#### 16.2 Definitions

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